

Application/Control No.	No. Applicant(s)/Patent under Reexamination	
10/736,629	FONG ET AL.	
Examiner	Art Unit	
Wilson Tsui	2178	

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Class	Subclass	Date	Examiner
715	513	4/25/2006	wt
715	514	4/25/2006	WT
715	523	4/25/2006	WT
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INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East Search Source and target documents, transform, translate, markup, hierarchy, tag and elements See Notes	4/25/2006	WT		
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